SPECIFICATIONS T_J = 25 °C, unless otherwise noted							
Parameter	**Symbol**	**Test Conditions**		**Min.**	**Typ.[a]**	**Max.**	**Unit**
Static							
Drain-Source Breakdown Voltage	V_{DS}	V_{GS} = 0 V, I_D = 1 mA	Ch-1	30			V
		V_{GS} = 0 V, I_D = 1 mA	Ch-2	30			
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	I_D = 250 µA	Ch-2		32		mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I_D = 250 µA	Ch-2		- 6		
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 1 mA	Ch-1	1		3	V
		V_{DS} = V_{GS}, I_D = 1 mA	Ch-2	1		3	
Gate-Body Leakage	I_{GSS}	V_{DS} = 0 V, V_{GS} = ± 20 V	Ch-1			100	nA
		V_{DS} = 0 V, V_{GS} = ± 20 V	Ch-2			100	
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 30 V, V_{GS} = 0 V	Ch-1		0.016	0.10	mA
		V_{DS} = 30 V, V_{GS} = 0 V	Ch-2			0.001	
		V_{DS} = 30 V, V_{GS} = 0 V, T_J = 100 °C	Ch-1		1.1	10	
		V_{DS} = 30 V, V_{GS} = 0 V, T_J = 100 °C	Ch-2			0.025	
On-State Drain Current[b]	$I_{D(on)}$	V_{DS} = 5 V, V_{GS} = 10 V	Ch-1	20			A
		V_{DS} = 5 V, V_{GS} = 10 V	Ch-2	20			
Drain-Source On-State Resistance[b]	$R_{DS(on)}$	V_{GS} = 10 V, I_D = 8 A	Ch-1		0.0156	0.020	Ω
		V_{GS} = 10 V, I_D = 8 A	Ch-2		0.0156	0.020	
		V_{GS} = 4.5 V, I_D = 5 A	Ch-1		0.019	0.025	
		V_{GS} = 4.5 V, I_D = 5 A	Ch-2		0.019	0.025	
Forward Transconductance[b]	g_{fs}	V_{DS} = 15 V, I_D = 8 A	Ch-1		29		S
		V_{DS} = 15 V, I_D = 8 A	Ch-2		29		
Dynamic[a]							
Input Capacitance	C_{iss}	Channel-1 V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz	Ch-1		950		pF
			Ch-2		950		
Output Capacitance	C_{oss}		Ch-1		185		
		Channel-2 V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz	Ch-2		155		
Reverse Transfer Capacitance	C_{rss}		Ch-1		65		
			Ch-2		65		
Total Gate Charge	Q_g	V_{DS} = 15 V, V_{GS} = 10 V, I_D = 8 A	Ch-1		16.5	25	nC
		V_{DS} = 15 V, V_{GS} = 10 V, I_D = 8 A	Ch-2		16.5	25	
		Channel-1 V_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 8 A	Ch-1		7.3	11	
			Ch-2		7.3	11	
Gate-Source Charge	Q_{gs}		Ch-1		2.7		
		Channel-2 V_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 8 A	Ch-2		2.7		
Gate-Drain Charge	Q_{gd}		Ch-1		2.1		
			Ch-2		2.1		
Gate Resistance	R_g	f = 1 MHz	Ch-1	0.2	1.2	2.4	Ω
			Ch-2	0.2	1.2	2.4	

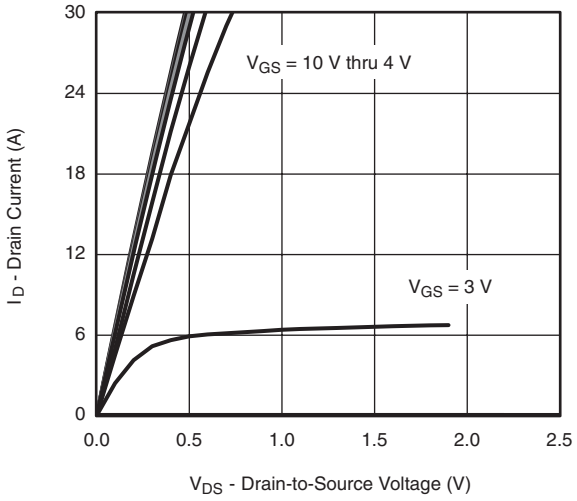
Notes:
a. Guaranteed by design, not subject to production testing.
b. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.

SPECIFICATIONS T_J = 25 °C, unless otherwise noted							
Parameter	**Symbol**	**Test Conditions**		**Min.**	**Typ.[a]**	**Max.**	**Unit**
Dynamic[a]							
Turn-On Delay Time	$t_{d(on)}$	Channel-1 V_{DD} = 15 V, R_L = 3 Ω $I_D \cong$ 5 A, V_{GEN} = 10 V, R_g = 1 Ω Channel-2 V_{DD} = 15 V, R_L = 3 Ω $I_D \cong$ 5 A, V_{GEN} = 10 V, R_g = 1 Ω	Ch-1		10	20	ns
			Ch-2		9	18	
Rise Time	t_r		Ch-1		10	20	
			Ch-2		11	20	
Turn-Off Delay Time	$t_{d(off)}$		Ch-1		18	35	
			Ch-2		18	35	
Fall Time	t_f		Ch-1		9	18	
			Ch-2		8	16	
Turn-On Delay Time	$t_{d(on)}$	Channel-1 V_{DD} = 15 V, R_L = 3 Ω $I_D \cong$ 5 A, V_{GEN} = 4.5 V, R_g = 1 Ω Channel-2 V_{DD} = 15 V, R_L = 3 Ω $I_D \cong$ 5 A, V_{GEN} = 4.5 V, R_g = 1 Ω	Ch-1		17	35	
			Ch-2		17	35	
Rise Time	t_r		Ch-1		12	24	
			Ch-2		12	24	
Turn-Off Delay Time	$t_{d(off)}$		Ch-1		19	35	
			Ch-2		18	35	
Fall Time	t_f		Ch-1		10	20	
			Ch-2		10	20	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	T_C = 25 °C	Ch-1			2.6	A
			Ch-2			2.6	
Pulse Diode Forward Current[a]	I_{SM}		Ch-1			30	
			Ch-2			30	
Body Diode Voltage	V_{SD}	I_S = 1 A	Ch-1		0.46	0.51	V
		I_S = 1 A	Ch-2		0.74	1.1	
Body Diode Reverse Recovery Time	t_{rr}	Channel-1 I_F = 5 A, dI/dt = 100 A/µs, T_J = 25 °C Channel-2 I_F = 5 A, dI/dt = 100 A/µs, T_J = 25 °C	Ch-1		17	34	ns
			Ch-2		17	34	
Body Diode Reverse Recovery Charge	Q_{rr}		Ch-1		7	14	nC
			Ch-2		9	18	
Reverse Recovery Fall Time	t_a		Ch-1		9		ns
			Ch-2		10		
Reverse Recovery Rise Time	t_b		Ch-1		8		
			Ch-2		7		

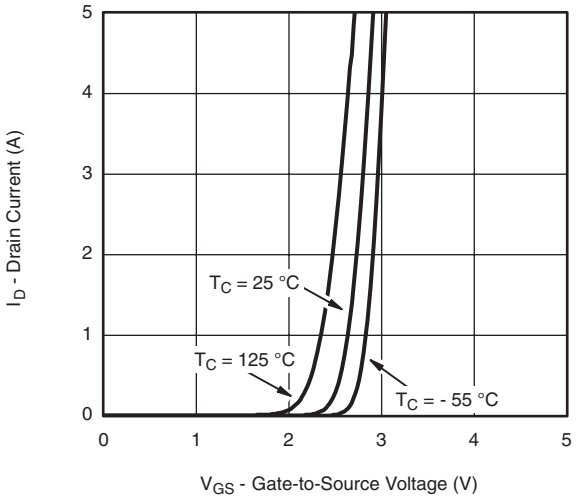
Notes:
a. Guaranteed by design, not subject to production testing.
b. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

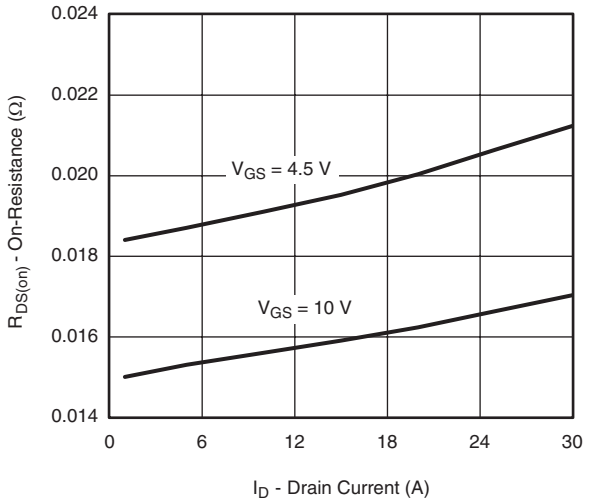
CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



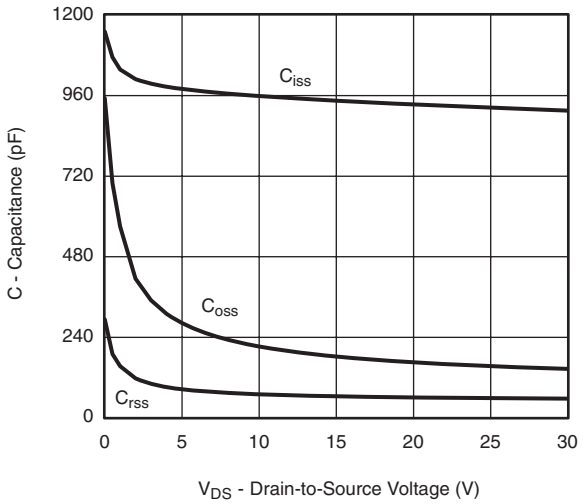
Output Characteristics



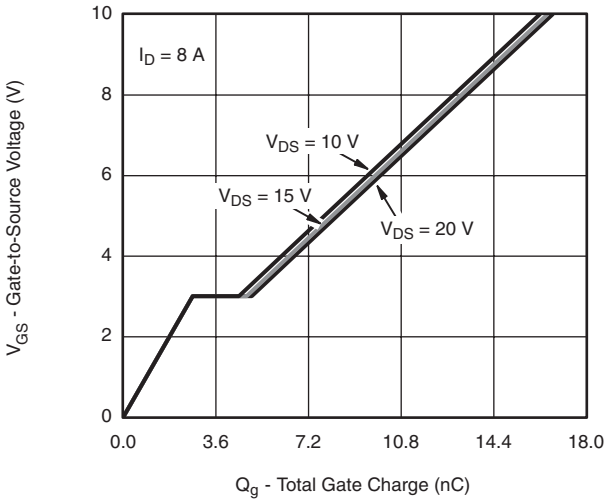
Transfer Characteristics



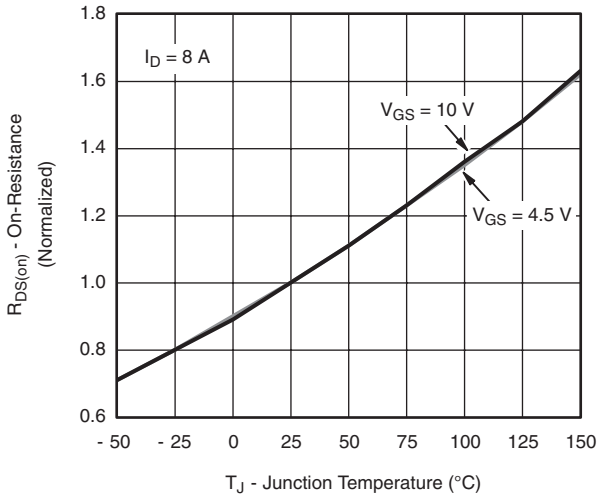
On-Resistance vs. Drain Current



Capacitance

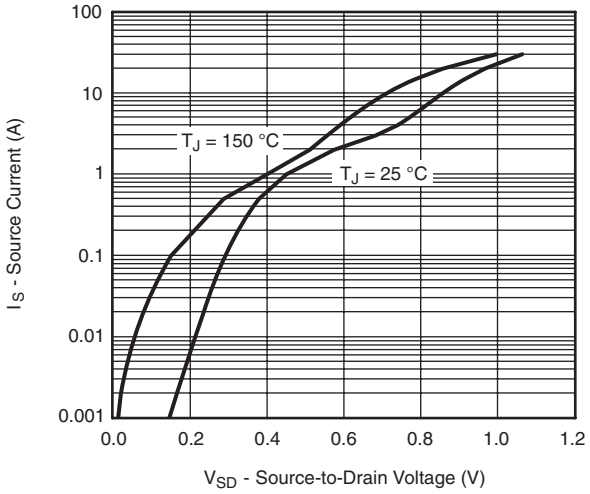


Gate Charge

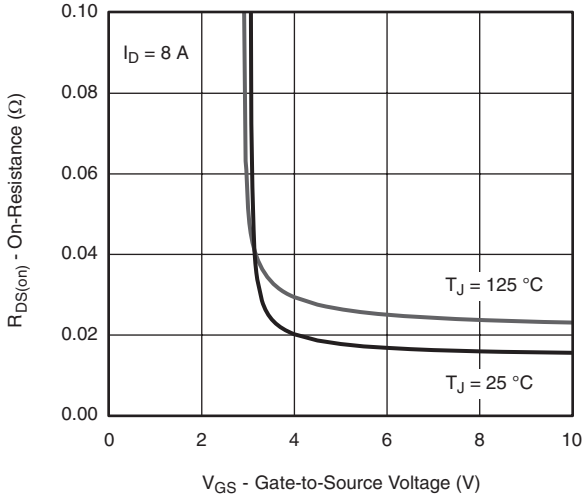


On-Resistance vs. Junction Temperature

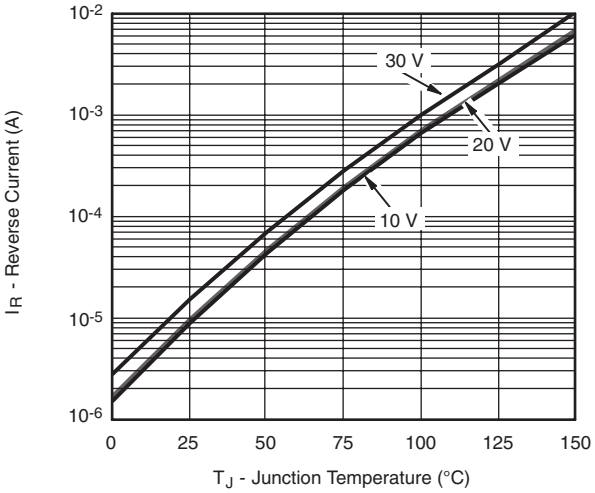
CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



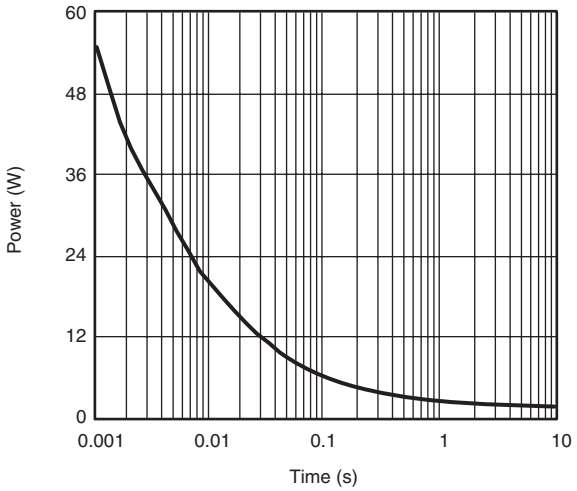
Source-Drain Diode Forward Voltage



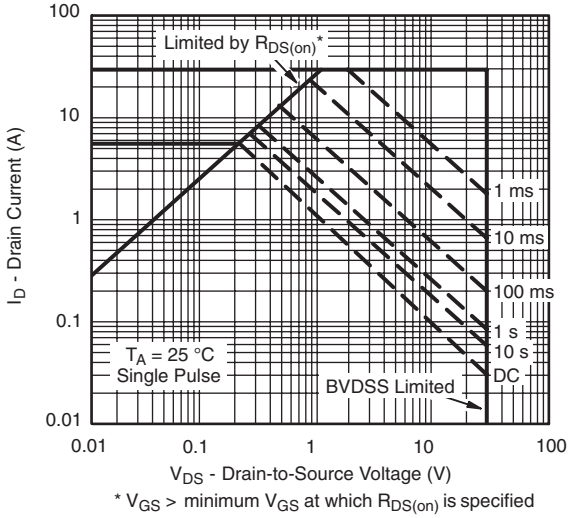
On-Resistance vs. Gate-to-Source Voltage



Reverse Current (Schottky)



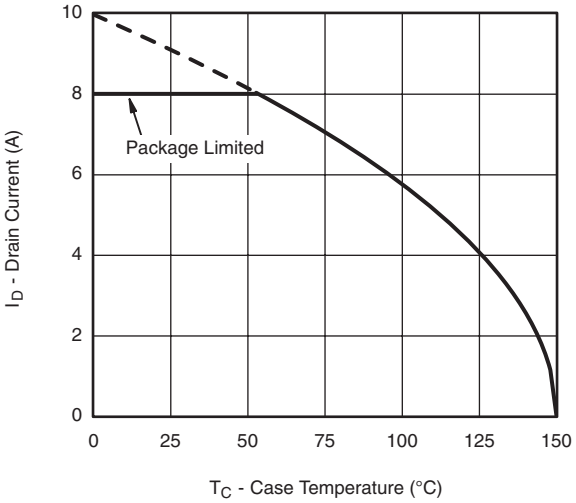
Single Pulse Power, Junction-to-Ambient



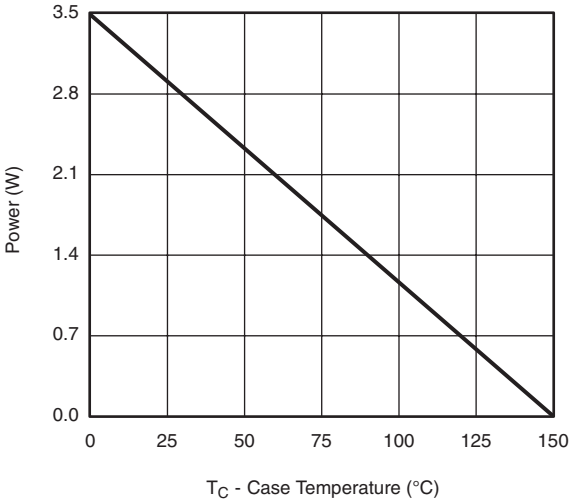
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

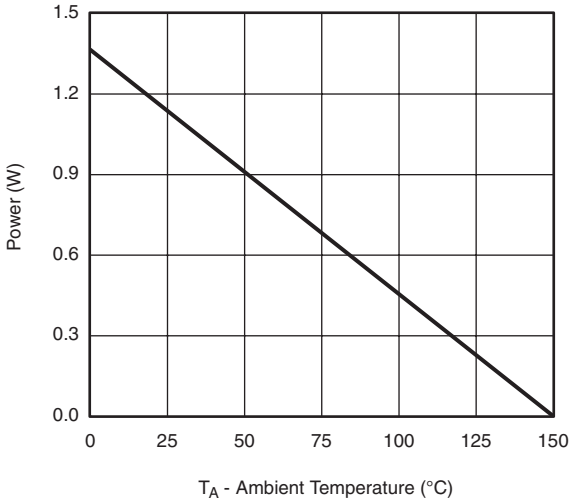
CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*



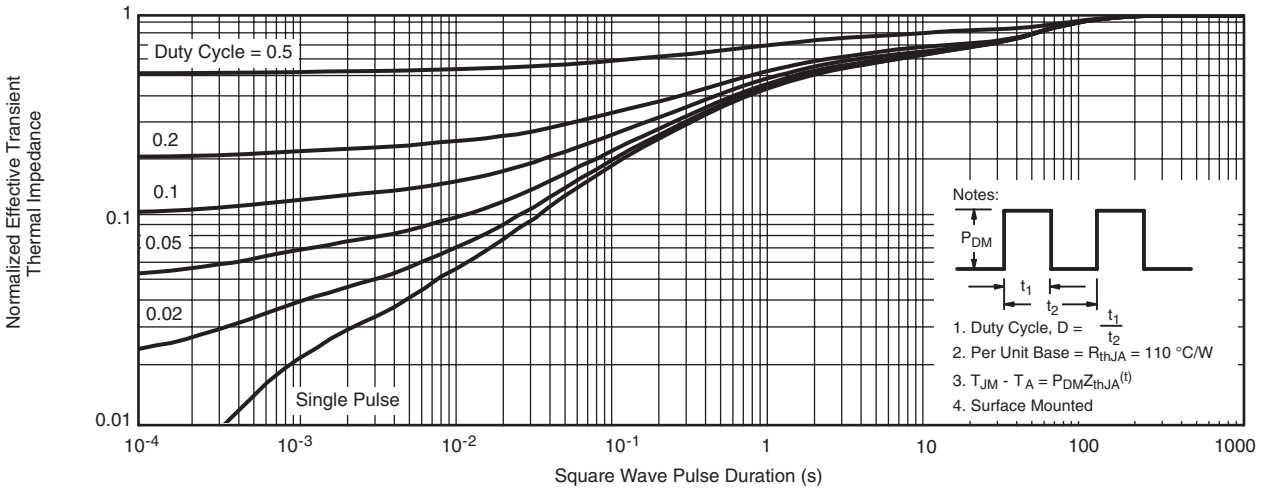
Power Derating, Junction-to-Foot



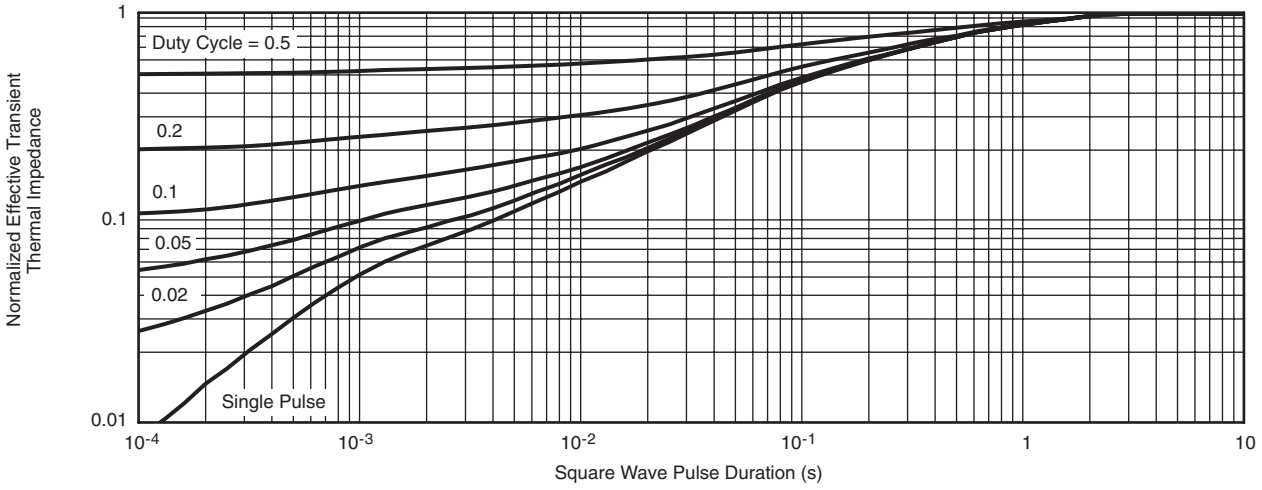
Power Derating, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

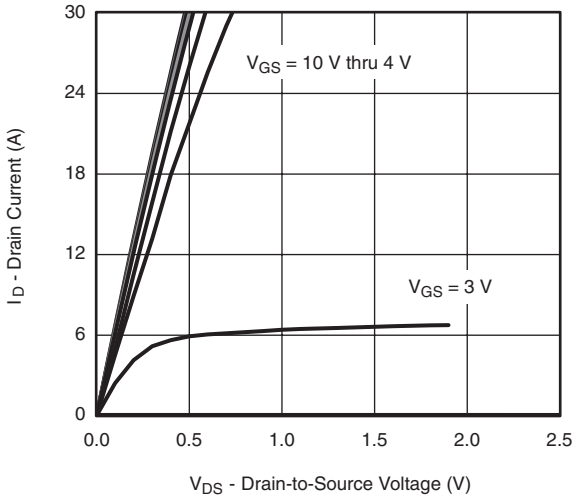


Normalized Thermal Transient Impedance, Junction-to-Ambient

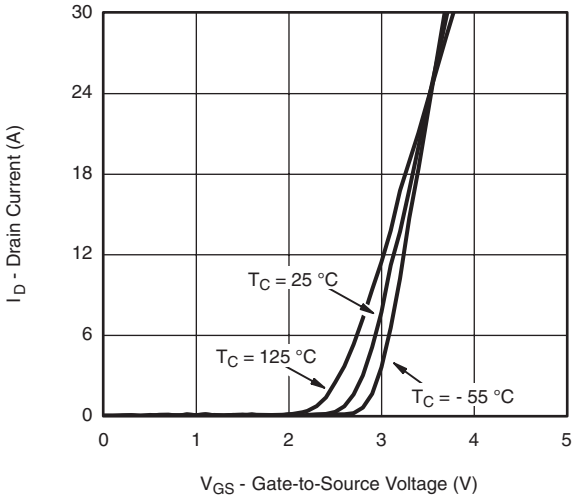


Normalized Thermal Transient Impedance, Junction-to-Foot

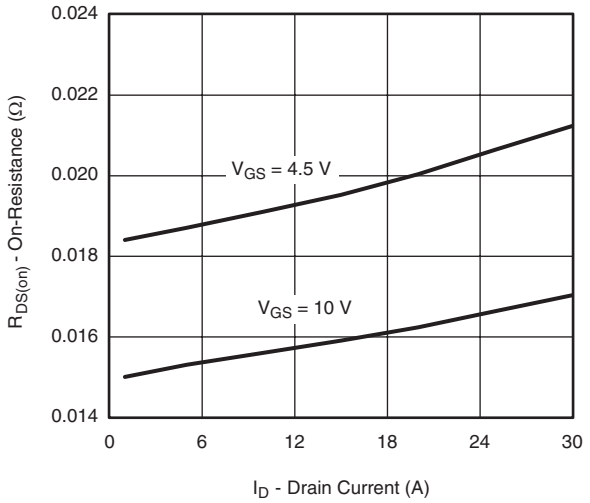
CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



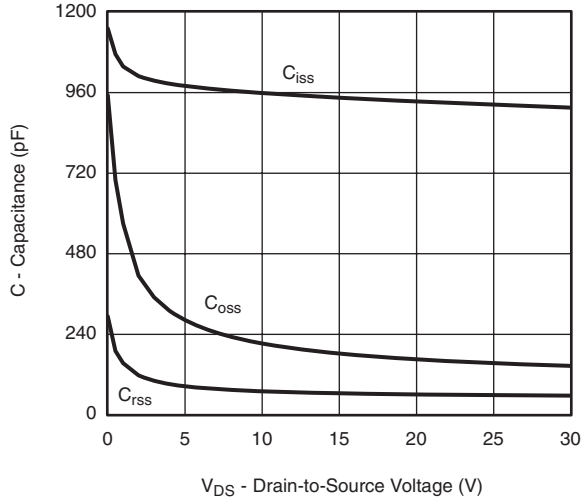
Output Characteristics



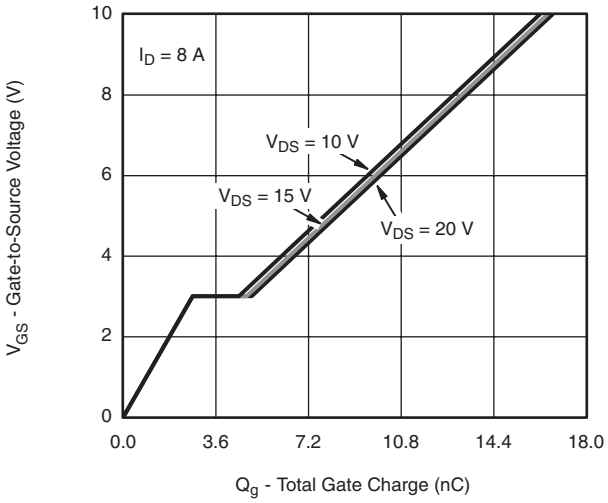
Transfer Characteristics



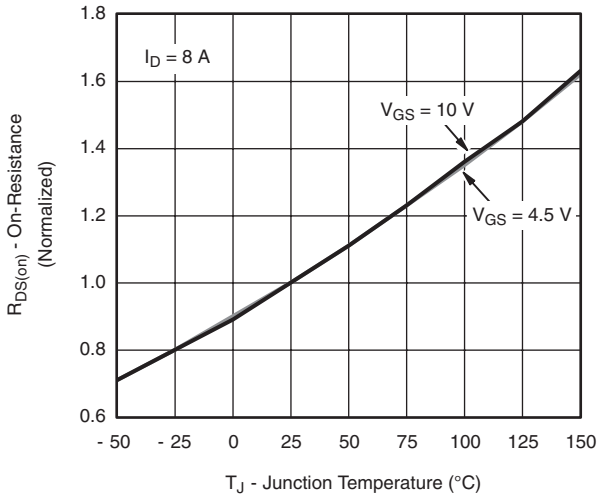
On-Resistance vs. Drain Current



Capacitance

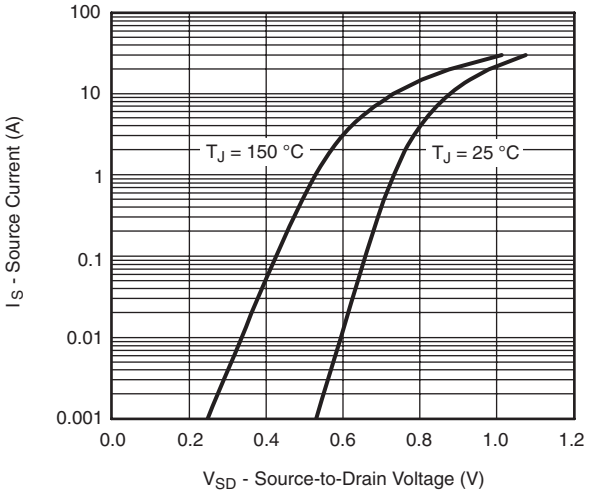


Gate Charge

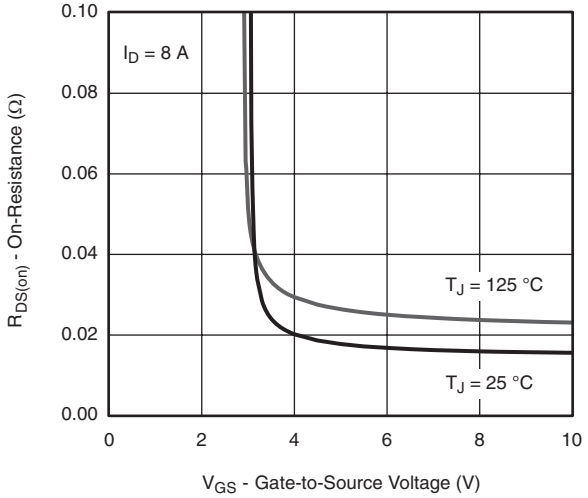


On-Resistance vs. Junction Temperature

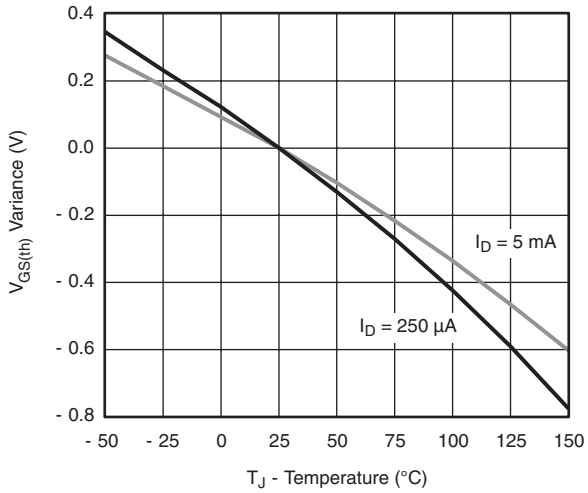
CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



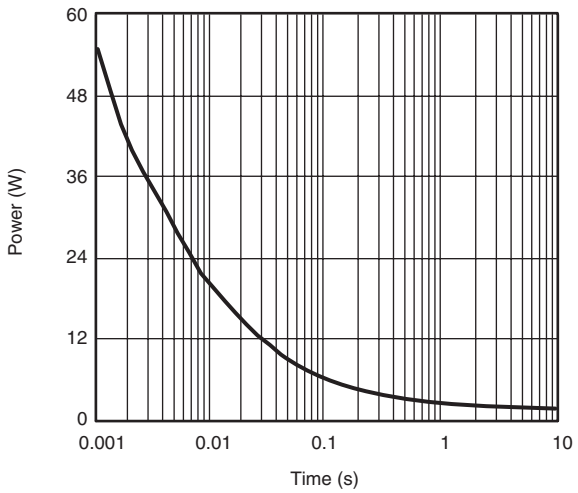
Source-Drain Diode Forward Voltage



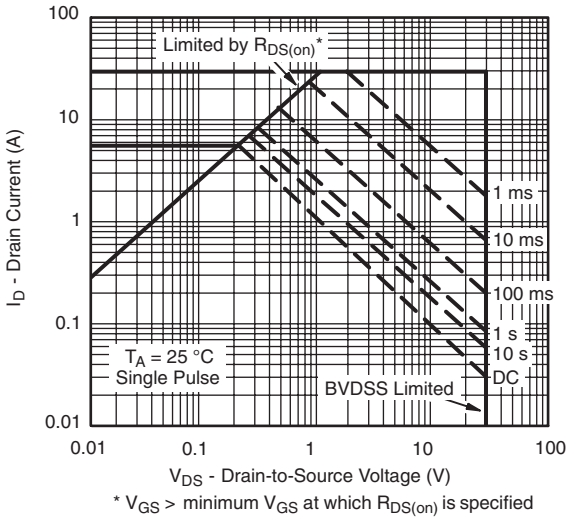
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



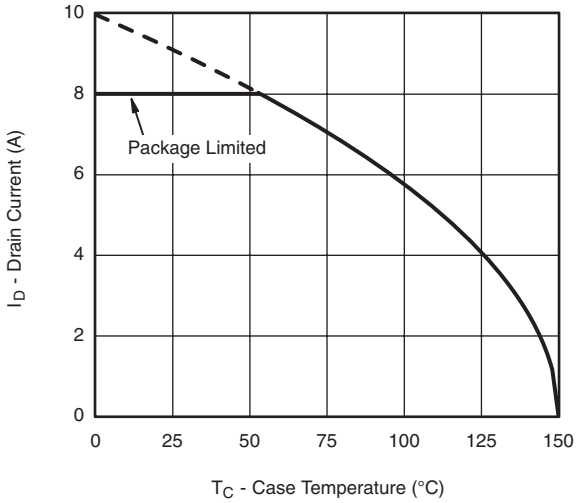
Single Pulse Power, Junction-to-Ambient



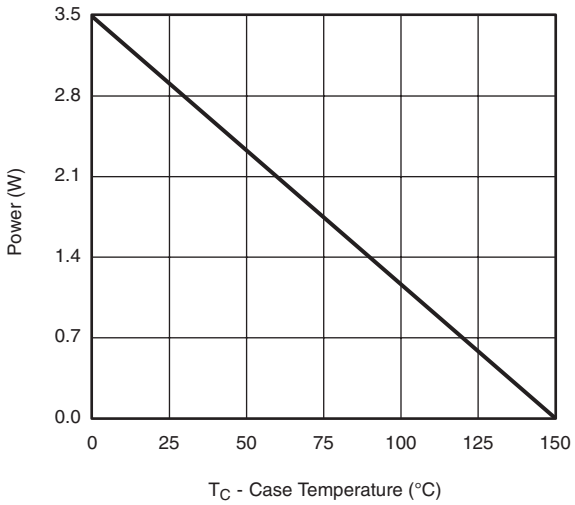
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

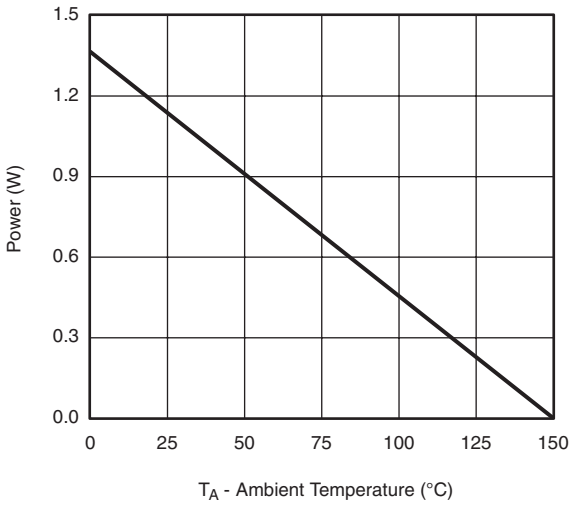
CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*



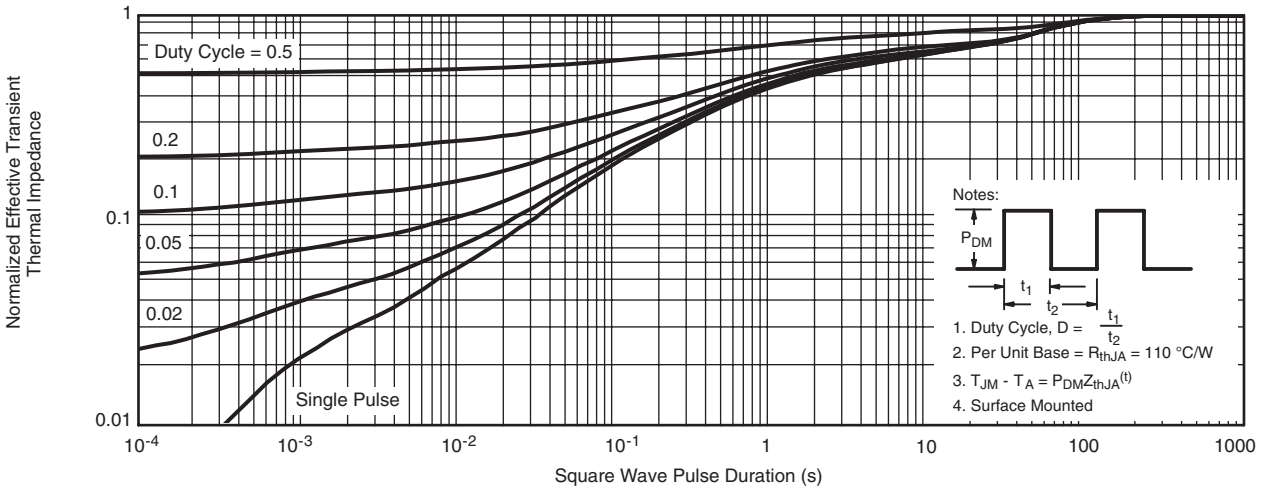
Power Derating, Junction-to-Foot



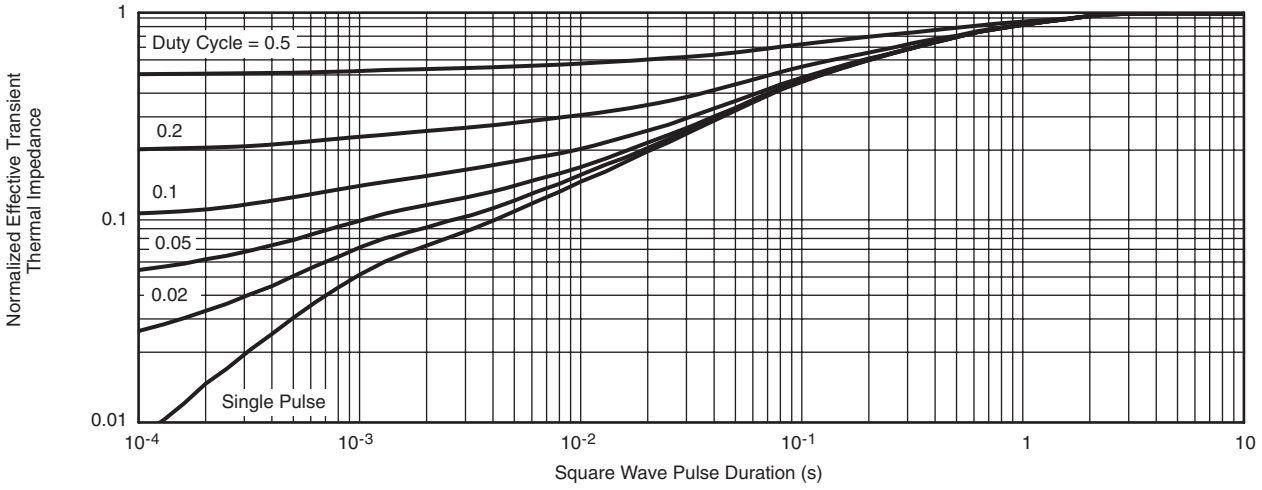
Power Derating, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



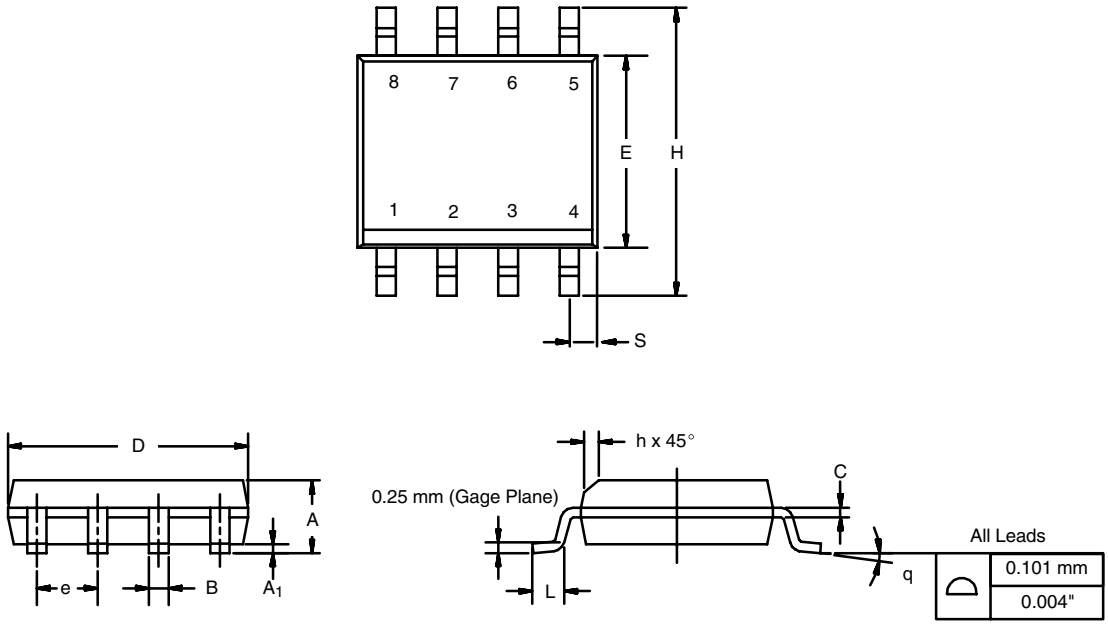
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

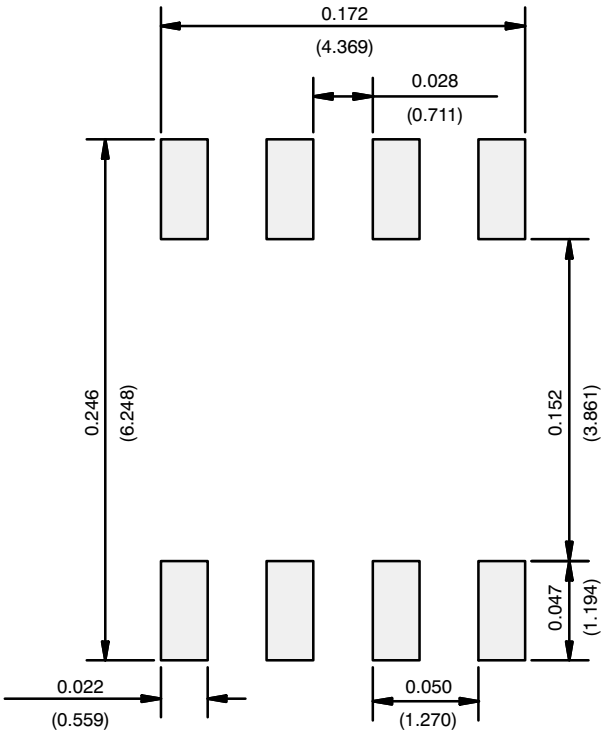
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?68790.

SOIC (NARROW): 8-LEAD
JEDEC Part Number: MS-012



DIM	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	1.35	1.75	0.053	0.069
A_1	0.10	0.20	0.004	0.008
B	0.35	0.51	0.014	0.020
C	0.19	0.25	0.0075	0.010
D	4.80	5.00	0.189	0.196
E	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
H	5.80	6.20	0.228	0.244
h	0.25	0.50	0.010	0.020
L	0.50	0.93	0.020	0.037
q	0°	8°	0°	8°
S	0.44	0.64	0.018	0.026
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498				

RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads
Dimensions in Inches/(mm)

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